

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	3514921	(EEPROM or ROM or RAM or (read near only near memory) or (flash near memory) or cell or EPROM or memory)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:33
L2	1621362	test or testing	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:35
L3	4045433	determined or predetermined	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:36
L4	13427	(deposit or depositing or deposition or growing or growth) near8 (gate near (insulating or insulator or insulated or oxide or dielectric))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:37
L5	915812	breakdown or threshold or ((state or interface or trapped or surface) near charge) or erase	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:38
L6	8602540	(temperature or pressure or duration or (flow near rate) or composition)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:39
L7	364	1 and 2 and 3 and 4 and 5 and 6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:41
L8	331	7 and ((@ad<"20030707") or (@rlad<"20030707"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:59

L9	30760	(deposition or thermal or growth or perform or performed or performing or deposit or deposited or depositing) near8 (gate near (insulator or insulation or insulating or insulated or oxide or dielectric))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:55
L10	320	8 and 9	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:56
L11	226	10 and parameter	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:56
L13	202	Sonderman.in. or Lall.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:57
L16	1054	(flash near memory) near8 (gate near (insulator or insulating or insulated or oxide or dielectric))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:58
L19	49600	Advanced.as.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:59
L20	66	16 and 19	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 14:59
L21	64	20 and ((@ad<"20030707") or (@rlad<"20030707"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 15:00

L22	5	21 and (test or testing)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/16 15:03
L23	2	("6133746").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/16 15:03
L24	4	("5548224" "5650336" "5793212" "5801538").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/16 15:03
L25	2	("6133746").URPN.	USPAT	OR	ON	2005/12/16 15:04